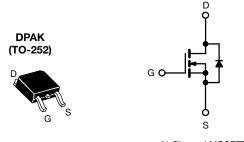


## N-Channel 800V (D-S) Super Junction Power MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V) at T <sub>J</sub> max.	800					
R <sub>DS(on)</sub> typ. (Ω) at 25 °C	$V_{GS} = 10 V$	2.38				
Q <sub>g</sub> max. (nC)	90					
Q <sub>gs</sub> (nC)	11					
Q <sub>gd</sub> (nC)	19					
Configuration	Single					



N-Channel MOSFET

### **FEATURES**

- Low figure-of-merit (FOM) Ron x Qa
- Low input capacitance (Ciss)
- Reduced switching and conduction losses
- Ultra low gate charge (Qg)
- Avalanche energy rated (UIS)



### **APPLICATIONS**

- Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- Lighting
  - High-intensity discharge (HID)
  - Fluorescent ballast lighting
- Industrial
- Welding
- Induction heating
- Motor drives
- Battery chargers
- Renewable energy
- Solar (PV inverters)

<b>ABSOLUTE MAXIMUM RATINGS</b> ( $T_C = 25 \text{ °C}$ , unless otherwise noted)									
PARAMETER			SYMBOL	LIMIT	UNIT				
Drain-source voltage		V <sub>DS</sub>	800	N					
Gate-source voltage			V <sub>GS</sub>	± 30	V				
Continuous drain current (T <sub>J</sub> = 150 °C)	V <sub>GS</sub> at 10 V	$T_{\rm C} = 25 \ ^{\circ}{\rm C}$ $T_{\rm C} = 100 \ ^{\circ}{\rm C}$	- I <sub>D</sub>	2.8					
		T <sub>C</sub> = 100 °C		1.8	A				
Pulsed drain current <sup>a</sup>			I <sub>DM</sub>	5					
Linear derating factor			0.5	W/°C					
Single pulse avalanche energy <sup>b</sup>			E <sub>AS</sub>	14	mJ				
Maximum power dissipation			PD	62.5	W				
Operating junction and storage temperature range		T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C					
Drain-source voltage slope	T <sub>J</sub> = 125 °C		-D (/-D	70					
Reverse diode dV/dt <sup>d</sup>		dV/dt	0.13	V/ns					
Soldering recommendations (peak temperature) <sup>c</sup>	For 10 s			300	°C				

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature

- b.  $V_{DD}$  = 140 V, starting  $T_J$  = 25 °C, L = 28.2 mH,  $R_g$  = 25  $\Omega,\,I_{AS}$  = 0.9 A
- c. 1.6 mm from case
- d.  $I_{SD} \leq I_D$ , dI/dt = 100 A/µs, starting  $T_J$  = 25 °C



THERMAL RESISTANCE RATI	NGS								
PARAMETER	SYMBOL	TYP.		<b>MAX.</b> 62		UNIT			
Maximum junction-to-ambient	R <sub>thJA</sub>	-							
Maximum junction-to-case (drain)	R <sub>thJC</sub>	- 2.0				°C/W			
<b>SPECIFICATIONS</b> (T <sub>J</sub> = 25 $^{\circ}$ C, U	Inless otherwi	se noted)							
PARAMETER	SYMBOL	TES	T CONDIT	IONS	MIN.	TYP.	MAX.	UNIT	
Static		•				•	•		
Drain-source breakdown voltage	V <sub>DS</sub>	V <sub>GS</sub> =	= 0 V, I <sub>D</sub> = 2	250 µA	800	-	-	V	
V <sub>DS</sub> temperature coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C,	$I_D = 1 \text{ mA}$	-	1.0	-	V/°C	
Gate-source threshold Voltage (N)	V <sub>GS(th)</sub>	V <sub>DS</sub> =	$V_{DS} = V_{GS}$ , $I_D = 250 \ \mu A$		2.0	-	4.0	V	
Gate-source leakage	I <sub>GSS</sub>	$V_{GS} = \pm 20 \text{ V}$			-	-	± 100	nA	
			$V_{GS} = \pm 30 \text{ V}$			-	± 1	μA	
Zero gate voltage drain current	1	$V_{DS} = 800 \text{ V}, V_{GS} = 0 \text{ V}$			-	-	1	μA	
	I <sub>DSS</sub>	V <sub>DS</sub> = 640 V	V <sub>DS</sub> = 640 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C			-	10		
Drain-source on-state resistance	R <sub>DS(on)</sub>	$V_{GS} = 10 V$	I	<sub>D</sub> = 1.0 A	-	2.38	-	Ω	
Forward transconductance	9 <sub>fs</sub>	V <sub>DS</sub>	= 30 V, I <sub>D</sub> :	= 1.0 A	-	1.0	-	S	
Dynamic									
Input capacitance	C <sub>iss</sub>		V <sub>GS</sub> = 0 \	/.	-	315	-		
Output capacitance	C <sub>oss</sub>	$V_{DS} = 100 V,$		-	20	-			
Reverse transfer capacitance	C <sub>rss</sub>		f = 1 MHz		-	6	-	-	
Effective output capacitance, energy related <sup>a</sup>	C <sub>o(er)</sub>	$V_{DS} = 0$ V to 480 V, $V_{GS} = 0$ V		-	13	-	pF		
Effective output capacitance, time related <sup>b</sup>	C <sub>o(tr)</sub>			-	45	-			
Total gate charge	Qg	V <sub>GS</sub> = 10 V I <sub>D</sub> = 1.0 A, V <sub>DS</sub> = 480 V			-	9.8	19.6		
Gate-source charge	Q <sub>gs</sub>			-	2.4	-	nC		
Gate-drain charge	Q <sub>gd</sub>				-	3.9	-		
Turn-on delay time	t <sub>d(on)</sub>	$V_{DD}$ = 480 V, I <sub>D</sub> = 1.0 A, V <sub>GS</sub> = 10 V, R <sub>g</sub> = 9.1 Ω		-	11	22	- ns		
Rise time	t <sub>r</sub>			-	7	14			
Turn-off delay time	t <sub>d(off)</sub>			-	19	38			
Fall time	t <sub>f</sub>			-	27	54			
Gate input resistance	R <sub>g</sub>	f = 1 MHz, open drain		1.8	3.6	7.2	Ω		
Drain-Source Body Diode Characteristic	cs								
Continuous source-drain diode current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	2.8	A		
Pulsed diode forward current	I <sub>SM</sub>			-	-	5			
Diode forward voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °C, I <sub>S</sub> = 11 A, V <sub>GS</sub> = 0 V		-	- 1	1.2	V		
Reverse recovery time	t <sub>rr</sub>	$T_J = 25 \text{ °C}, I_F = I_S = 1.0 \text{ A},$ dl/dt = 100 A/ $\mu$ s, V <sub>R</sub> = 25 V		-	278	556	ns		
Reverse recovery charge	Q <sub>rr</sub>			-	0.9	1.8	μC		
Reverse recovery current	I <sub>RRM</sub>			-	5	-	A		

#### Notes

a.  $C_{oss(er)}$  is a fixed capacitance that gives the same energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ b.  $C_{oss(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ 



### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

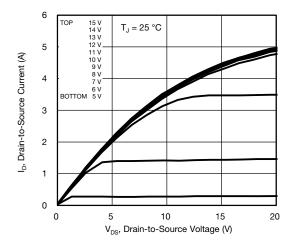


Fig. 1 - Typical Output Characteristics

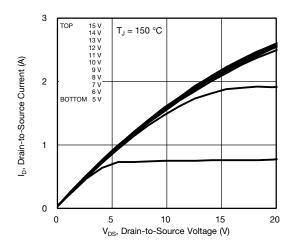


Fig. 2 - Typical Output Characteristics

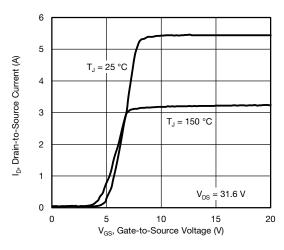


Fig. 3 - Typical Transfer Characteristics

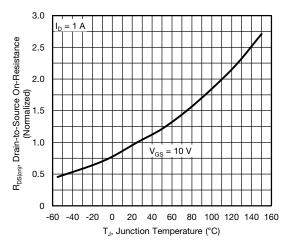


Fig. 4 - Normalized On-Resistance vs. Temperature

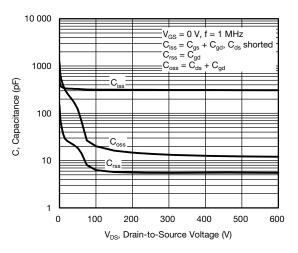


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

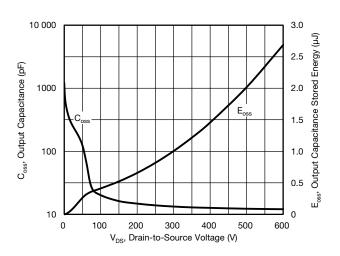


Fig. 6 -  $C_{oss}$  and  $E_{oss}$  vs.  $V_{DS}$ 

### FIR3N80LG



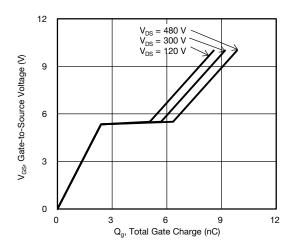


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

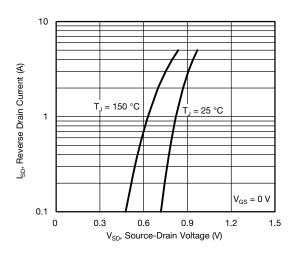


Fig. 8 - Typical Source-Drain Diode Forward Voltage

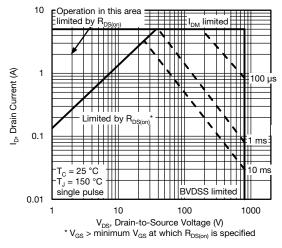


Fig. 9 - Maximum Safe Operating Area

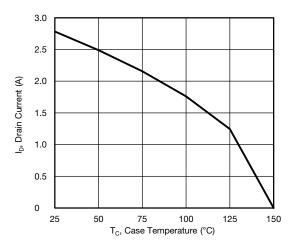


Fig. 10 - Maximum Drain Current vs. Case Temperature

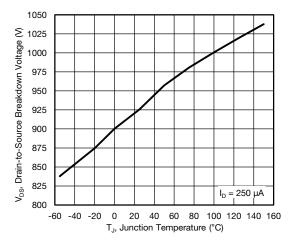
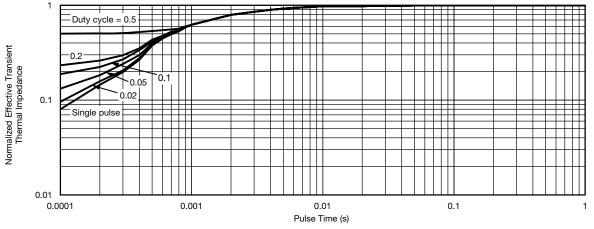


Fig. 11 - Temperature vs. Drain-to-Source Voltage

### FIR3N80LG





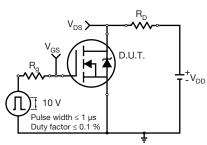


Fig. 13 - Switching Time Test Circuit

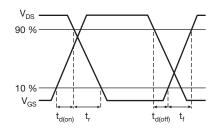


Fig. 14 - Switching Time Waveforms

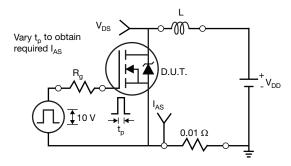


Fig. 15 - Unclamped Inductive Test Circuit

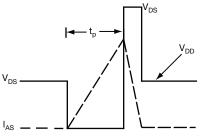


Fig. 16 - Unclamped Inductive Waveforms

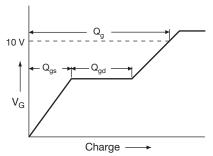


Fig. 17 - Basic Gate Charge Waveform

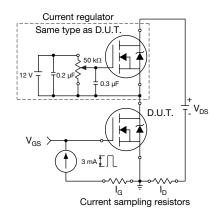


Fig. 18 - Gate Charge Test Circuit

Bsemi

www.VBsemi.com



### Peak Diode Recovery dV/dt Test Circuit

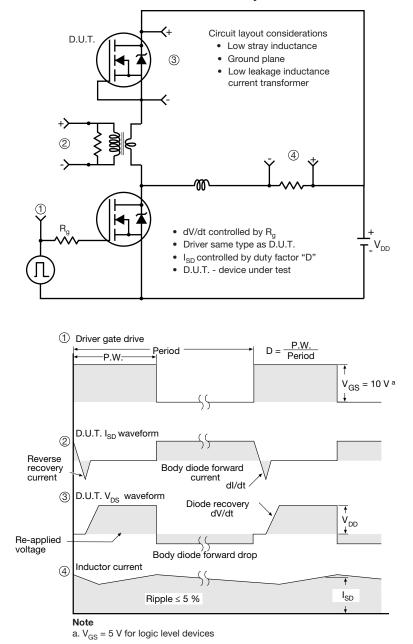


Fig. 19 - For N-Channel



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